## Applicant(s)/Patent Under Application/Control No. Reexamination 10/605,655 CHENG ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 2621 Albert H. Cutler **U.S. PATENT DOCUMENTS** Document Number Date Classification Name Country Code-Number-Kind Code MM-YYYY 348/231.2 US-6,970,192 11-2005 Takayama, Nobutoshi Α US-В С US-US-D US-

## FOREIGN PATENT DOCUMENTS

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